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List of DORIS III beamlines in 2012

Δ1 Χ	A1 X-ray absorption spectroscopy					
	Bending magnet (Ec = 16 keV)					
	Instrument for in-situ XAFS including fast energy scanning	2.4 – 8 keV	DESY			
A2 S	A2 Small-angle X-ray scattering					
	Bending magnet (Ec = 16 keV)					
	Multi setup instrument for (simultaneous) small and wide	8 keV	DESY			
D ()	angle scattering from soft matter samples	0 10 1	DEGT			
B1 A	nomalous small-angle X-ray scattering					
	Bending magnet (Ec = 16 keV)					
	Instrument for anomalous scattering (ASAXS)	5 – 35 keV	DESY			
B2 X	-ray powder diffraction					
	Bending magnet (Ec = 16 keV)					
	Heavy duty diffractometer including special setups for in-situ	5 – 44 keV	DESY			
BW1	studies X-ray diffraction / scattering					
DWI	BW1 X-ray diffraction / scattering					
	4 m X-ray undulator					
	Horizontal diffractometer for liquid surface scattering	9.5 keV	DESY			
	UHV instrument for surface diffraction / standing waves including MBE sample preparation	2.4 – 12 keV	DESY U Bremen			
	Multi purpose heavy load 8-circle diffractometer	5 – 18 keV	DESY			
-	Rheometer	9.9 keV	DESY			
BW2	X-ray spectroscopy / diffraction / tomography					
	4 m X-ray wiggler (Ec = 15.4 keV)					
	UHV instrument for hard X-ray photoelectron spectroscopy	2.4 – 10 keV	DESY			
	X-ray micro-tomography setup	6 – 24 keV	HZG			
	Heavy load vertical diffractometer with CCD detector arm for grazing incidence diffraction	5 – 11 keV	DESY			
BW3	Soft X-ray spectroscopy					
	4 m XUV (double) undulator					
	High-resolution SX-700 plane grating monochromator,	50 – 1500 eV	DESY			
	beam port for user supplied instruments	50 – 1500 ev	DEST			
BW4 Ultra small-angle X-ray scattering						
	2.7 m X-ray wiggler (Ec = 15.4 keV)					
	Flexible instrument for (ultra) small angle (grazing incidence) scattering experiments	6 – 14 keV	DESY			
BW5	BW5 High-energy X-ray diffraction					
	4 m X-ray wiggler (Ec = 26 keV)					
	Triple axis diffractometer in horizontal Laue scattering					
	geometry including high magnetic field (10 T) sample environment	60 – 250 keV	DESY			

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BW7	A Macromolecular crystallography			
	4 m X-ray wiggler (Ec = 15.4 keV) Crystallographic end-station with CCD detector, double			
	multilayer optics, optimized for high-flux fast data collection	12.8 keV	EMBL	
BW7	B Macromolecular crystallography			
	4 m X-ray wiggler (Ec = 15.4 keV)			
	Crystallographic end-station with CCD detector, new high-			
	precision Phi spindle, EMBL Hamburg robotic sample	14.7 keV	EMBL	
C X-	changer (MARVIN) ray absorption spectroscopy / diffraction			
U A	Bending magnet (Ec = 16 keV)			
	Setup for high-energy XAFS in-situ studies including fast			
	energy scanning	5 – 44 keV	DESY	
	Vertical diffractometer for grazing incidence X-ray diffraction	5 – 44 keV	DESY	
D1 ()	X33) Small-angle X-ray scattering			
	Bending magnet (Ec = 16 keV)			
	Instrument optimized for automated solution scattering	8 keV	EMBL	
D2 0	studies of biological macromolecules			
D3 C	Chemical crystallography			
	Bending magnet (Ec = 16 keV) 4-circle diffractometer	8 – 50 keV	DESY	
	razing incidence X-ray scattering	0 - 50 Kev	DEST	
D4 C				
	Bending magnet (Ec = 16 keV)	5 20 kg//	DECV	
E1 /	2-circle diffractometer, horizontal scattering plane Flipper2) Soft X-ray spectroscopy	5 – 20 keV	DESY	
	Bending magnet (Ec = 16 keV)			
ED V	UHV instrument for soft X-ray photoelectron spectroscopy	10 – 150 eV	U Hamburg	
	-ray reflectometry / grazing incidence diffraction			
	Bending magnet (Ec = 16 keV)	1		
	6-circle diffractometer for reflectometry & high-resolution	4 – 35 keV	DESY /	
E1 C	diffraction hemical crystallography		RWTH Aachen	
	Bending magnet (Ec = 16 keV)	5 – 41 keV		
	Kappa-diffractometer for low/high-temperature / high- pressure single-crystal diffraction	white beam	U Hamburg	
F2 X	-ray diffraction / VUV spectroscopy			
	Bending magnet (Ec = 16 keV)			
	Hutch1 MAX80 Multi-Anvil-X-ray apparatus for high	5 – 80 keV	057	
	pressure X-ray diffraction	white beam	GFZ	
	Hutch2 UHV instrument for angle-resolved UV photoelectron	5 – 41 eV	U Hamburg	
F3 F	nergy dispersive scattering			
	Bending magnet (Ec = 16 keV)		DESY	
	Horizontal diffractometer with heavy load sample stage	white beam	U Kiel	

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F4 X-ray test beam		
Bending magnet (Ec = 16 keV)		
Used for detector characterization		DESY
G3 Diffraction X-ray imaging	-	
Bending magnet (Ec = 16 keV)		
4-circle diffractometer for position resolved diffraction	5.4 – 26 keV	DESY
I Superlumi) UV luminescence spectroscopy		·
Bending magnet (Ec = 16 keV)		
Superlumi setup for luminescence analysis	3-40 eV	DESY
K1.1 (X11) Macromolecular crystallography		
Bending magnet (Ec = 16 keV)		
Crystallographic end-station with large surface area flat	15.3 keV	EMBL
panel detector, cryoshutter, single horizontal axis of rotation K1.2 (X12) Macromolecular crystallography	10.0 KeV	LIVIDE
Bending magnet (Ec = 16 keV) Crystallographic end-station with CCD and fluorescence		
detector, single axis of rotation, opt. for MAD and SAD	6 – 18 keV	EMBL
K1.3 (X13) Macromolecular crystallography		
Bending magnet (Ec = 16 keV)		
Crystallographic end-station with CCD detector, cryoshutter,		
micro-spectrophotometer, single horizontal axis of rotation,	15.3 keV	EMBL
optimised for automated expert data collection		
L X-ray micro probe		
Bending magnet (Ec = 16 keV)		
X-ray microprobe combining fluorescence analysis,	5 – 80 keV	DESY
absorption spectroscopy and diffraction	white beam	BEOT
W1 X-ray spectoscopy / diffraction		
2 m X-ray wiggler (Ec = 8 keV)		
High-resolution fluorescence in vacuo spectrometer	4 – 11.5 keV	DESY
Heavy load diffractometer for grazing incidence diffraction in vertical or horizontal scattering geometry	4 – 11.5 keV	DESY
W2 (HARWI II) High-energy X-ray engineering materia	ls science	
4 m X-ray wiggler (Ec = 26 keV)		
Hutch1 Materials Science Diffractometer	60 – 250 keV	HZG
(heavy load up to 600 kg)		
Micro-tomography setup	20 – 250 keV	HZG
(attenuation and phase contrast)		
Diffraction-tomography "DITO" instrument	20 – 150 keV	TU Dresden TU Berlin
Hutch2 MAX200x Multi-Anvil X-ray apparatus for high	white beam	GFZ
pressure and temperature conditions X1 X-ray absorption spectroscopy		
Bending magnet (Ec = 16 keV)		
Setup for high-energy fast-scanning XAFS for in-situ studies		
including chemistry lab	7 – 100 keV	DESY